## Application/Control No. Applicant(s)/Patent Under Reexamination 10/825,816 KIM ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Chuc D. Tran 2821 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	ŮS-5,901,116	05-1999	Quine, Richard W.	. 368/117
, *	В	US-4,745,607	05-1988	Koch, Thomas L.	372/45.01
*	С	US-5,757,832	05-1998	Uchida, Mamoru	372/45.01
*	D	US-5,347,533	09-1994	Higashi et al.	372/96
*	Е	US-5,586,131	12-1996	Ono et al.	372/19
	F	US-			
	G	US-			
	н	US-			
	_	US-			
	7	US-			,
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				·	
	Р		1			
	Q					
L_	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	>						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.